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GATE

7 🛛 B1

6 B2

DCT OR DCU PACKAGE (TOP VIEW)

8

5 B3

GND

A1 🛛 2

A2 [

A3 🛛 4

3

- Designed to Be Used in Voltage-Limiting Applications
- 3.5-Ω On-State Connection Between Ports A and B
- Flow-Through Pinout for Ease of Printed Circuit Board Trace Routing
- Direct Interface With GTL+ Levels
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

description

The SN74TVC3306 provides three parallel NMOS pass transistors with a common unbuffered gate. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

The device can be used as a dual switch, with the gates cascaded together to a reference transistor. The low-voltage side of each pass transistor is limited to a voltage set by the reference transistor. This is done to protect components with inputs that are sensitive to high-state voltage-level overshoots.

ORDERING INFORMATION

т _А	PACKA	AGE [†]	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
40°C to 95°C	SSOP – DCT	Tape and reel	SN74TVC3306DCTR	FA6		
-40°C to 85°C	VSSOP - DCU	Tape and reel	SN74TVC3306DCUR	FA6		

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

logic diagram (positive logic)



NOTE A: The SN74TVC3306 has bidirectional capability across many voltage levels. The voltage levels documented in this data sheet are examples.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Input voltage range, V _I (see Note 1)	0.5 V to 7 V
Input/output voltage range, $V_{I/O}$ (see Note 1)	–0.5 V to 7 V
Continuous channel current	128 mA
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Package thermal impedance, θ_{JA} (see Note 2): DCT package	220°C/W
DCU package	227°C/W
Storage temperature range, T _{stg}	. −65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and input/output negative-voltage ratings may be exceeded if the input and input/output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions

		MIN	MAX	UNIT
V _{I/O}	Input/output voltage	0	5	V
VGATE	GATE voltage	0	5	V
IPASS	Pass transistor current		64	mA
TA	Operating free-air temperature	-40	85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN TY	P‡	MAX	UNIT
VIK	I _I = -18 mA,		V _{GATE} = 0			-1.2	V
Чн	V _I = 5 V,	I = 5 V, V _{GATE} = 0				5	μA
C _{i(GATE)}	V _I = 3 V or 0				11		pF
C _{io(off)}	V _O = 3 V or 0,			4	6	pF	
C _{io(on)}	V _O = 3 V or 0,		1	0.5	12.5	pF	
			V _{GATE} = 4.5 V	:	3.5	5.5	
	$V_{\rm L} = 0$	$l_{0} = 64 \text{ mA}$	V _{GATE} = 3 V		4.7	7	
	vi = 0	0 - 04 mA	V _{GATE} = 2.3 V		5.3	9.5	
r _{on} §			V _{GATE} = 1.5 V	2	5.5	32	Ω
	$\lambda = 2.4 \lambda$		V _{GATE} = 4.5 V		4.8	7.5	
	v] = 2.4 v	I _O = 15 mA	V _{GATE} = 3 V	1.	4.7	23	
	V _I = 1.7 V]	V _{GATE} = 2.3 V	1	1.3	16.5	

[‡] All typical values are at $T_A = 25^{\circ}C$.

§ Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lowest voltage of the two (A or B) terminals.



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ac performance (translating down)

switching characteristics over recommended operating free-air temperature range, $V_{GATE} = 3.3 V$, $V_{IH} = 3.3 V$, $V_{IL} = 0$, and $V_{M} = 1.15 V$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	C _L = 50 pF		C _L = 30 pF		C _L = 15 pF		
	(INPUT) (OUTPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A or B	P.or A	0	0.8	0	0.6	0	0.3	20
^t PHL		BUIA	0	1.2	0	1	0	0.5	115

switching characteristics over recommended operating free-air temperature range, $V_{GATE} = 2.5 V$, $V_{IL} = 0$, and $V_{M} = 0.75 V$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	C _L = 50 pF		C _L = 30 pF		C _L = 15 pF		
	(INPUT) (OUTPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A or B	Por	0	1	0	0.7	0	0.4	
^t PHL		BUIA	0	1.3	0	1	0	0.6	115

ac performance (translating up)

switching characteristics over recommended operating free-air temperature range, V_{GATE} = 3.3 V, V_{IH} = 2.3 V, V_{IL} = 0, V_{T} = 3.3 V, V_{M} = 1.15 V, and R_{L} = 300 Ω (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	C _L = 50 pF		C _L = 30 pF		C _L = 15 pF		
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A or B	D or A	0	0.9	0	0.6	0	0.4	
^t PHL		BUIA	0	1.4	0	1.1	0	0.7	115

switching characteristics over recommended operating free-air temperature range, $V_{GATE} = 2.5 V$, $V_{IH} = 1.5 V$, $V_{IL} = 0$, $V_T = 2.5 V$, $V_M = 0.75 V$, and $R_L = 300 \Omega$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	C _L = 50 pF		C _L = 30 pF		C _L = 15 pF		
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A or B	P. or A	0	1	0	0.6	0	0.4	
^t PHL		BUIA	0	1.3	0	1.3	0	0.8	115



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.
- C. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit for Outputs



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APPLICATION INFORMATION

[†]V_{REF} and V_{BIAS} can be applied to any one of the pass transistors. GATE must be connected externally to V_{BIAS}.

Figure 2. Typical Application Circuit

For the clamping configuration, the common GATE input must be connected to one side (An or Bn) of any one of the pass transistors, making that the V_{BIAS} connection of the reference transistor and the opposite side (Bn or An) the V_{REF} connection. When V_{BIAS} is connected through a 200-k Ω resistor to a 3-V to 5.5-V V_{CC} supply and V_{REF} is set to 0 V to V_{CC} – 0.6 V, the output of each switch has a maximum clamp voltage equal to V_{REF}. A filter capacitor on V_{BIAS} is recommended.

application operating conditions (see Figure 2)

		MIN	түр‡	MAX	UNIT
VBIAS	BIAS voltage	V _{REF} + 0.6	2.1	5	V
VGATE	GATE voltage	V _{REF} + 0.6	2.1	5	V
V _{REF}	Reference voltage	0	1.5	4.4	V
VDPU	Drain pullup voltage	2.36	2.5	2.64	V
IPASS	Pass-transistor current		14		mA
IREF	Reference-transistor current		5		μA
TA	Operating free-air temperature	-40		85	°C

[‡] All typical values are at $T_A = 25^{\circ}C$.



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Mailing Address:

Texas Instruments Post Office Box 655303 Dallas, Texas 75265

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